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| FORM PTO-1449   | SERIAL NO.                   | CASE NO.<br>N0178US |
| LIST OF PATENTS AND PUBLICATIONS FOR<br>APPLICANT'S INFORMATION DISCLOSURE<br>STATEMENT | FILING DATE                  | GROUP ART UNIT      |
| (use several sheets if necessary)   | APPLICANT(S): Natesan et al. |                     |

**REFERENCE DESIGNATION U.S. PATENT DOCUMENTS**

| EXAMINER<br>INITIAL |     | DOCUMENT<br>NUMBER | DATE    | NAME                       | CLASS/<br>SUBCLASS | FILING<br>DATE |
|---------------------|-----|--------------------|---------|----------------------------|--------------------|----------------|
| AS                  | A1  | 6546334            | 04/2003 | Fukuchi et al.             |                    |                |
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**FOREIGN PATENT DOCUMENTS**

| EXAMINER<br>INITIAL |     | DOCUMENT<br>NUMBER | DATE    | COUNTRY | CLASS/<br>SUBCLASS | TRANSLATION<br>YES | NO |
|---------------------|-----|--------------------|---------|---------|--------------------|--------------------|----|
| AS                  | A19 | WO 00/46776        | 8/2000  | PCT     |                    | x                  |    |
| AS                  | A20 | WO 98/45823        | 10/1998 | PCT     |                    | x                  |    |
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| EXAMINER<br>INITIAL | OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.) |
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|-----------------------------|-------------------------------|
| EXAMINER<br>/Andrew Setlak/ | DATE CONSIDERED<br>04/30/2006 |
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